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# APPROVAL SHEET

Customer Name	:		
Customer P/N	:		
Frequency	:	48.000000	MHz
Aker Approved P/N		SMBN-048000-7-D4-00	
Aker MPN		SMBN-048000-7-D4-00	
Rev.		1	
ISSUE DATE		Feb.13.2023	

APPROVED	CHECKED	PREPARED
(in		Xīn
APPROVED BY CUST	OMER	

# AKER TECHNOLOGY CO., LTD.

ADDRESS : NO 11-3, Jianguo Rd., Tanzi Dist., Taichung City 427, Taiwan.

TEL: 886-4-25335978 FAX: 886-4-25336011

Web: www.aker.com.tw

MSL:Level 1 RoHS compliant



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Rev.	Date	Reviser	Revise contents
1	2023/2/13	Xin	Initial Released



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# SMD CRYSTAL OSCILLATOR

#### **1. ELECTRICAL CHARACTERISTICS**

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurement

and tests are as follow :

Ambient temperature :  $25\pm5$  °C

Relative humidity : 40%~70%

If there is any doubt about the results, measurement shall be made within the following limits:

Ambient temperature : 25±3 °C

Relative humidity : 40%~70%

■ AKER Model : SMBN-751

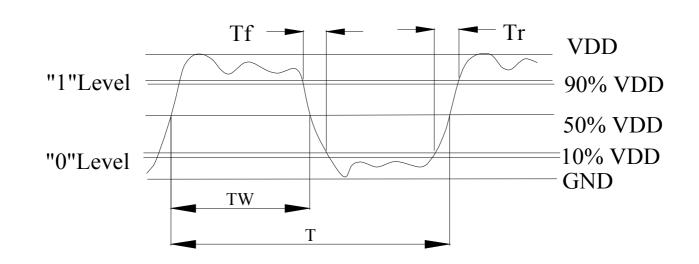
• Cutting Mode : AT CUT

		Electrical Spec				
Parameters	Symbol	Min.	Тур.	Max.	Units.	Notes
Nominal Frequency		4	8.00000	0	MHz	
Frequency Stability			±100		ppm	
Supply Voltage	Vcc	1.62	2	3.63	V	
Output Load CMOS	CL			15	pF	
Aging			$\pm 3$		ppm	First Year
Enable Control			Yes			Pad 1
Operating Temperature		-40	25	105	°C	
Storage Temperature Range		-55	2	125	°C	
Output Voltage High	VoH	90%Vdd			V	
Output Voltage Low	VoL			10%Vdd	V	
Input Current	Icc			20	mA	
Standby Current	Ist			20	μA	
Rise Time	Tr			10	ns	10%~90%VDD Level
Fall Time	Tf			10	ns	90%~10%VDD Level
Symmetry (Duty ratio)	TH/T	45	2	55	%	
Start-up Time	Tosc			10	ms	
Enable Voltage High	Vhi	70%Vdd			V	
Disable Voltage Low	Vlo			30%VDD	V	
Output Enable Delay Time	T on			10	ms	
Output Disable Delay Time	T off			200	ns	
Phase Jitter RMS				1	ps	12KHz~20MHz

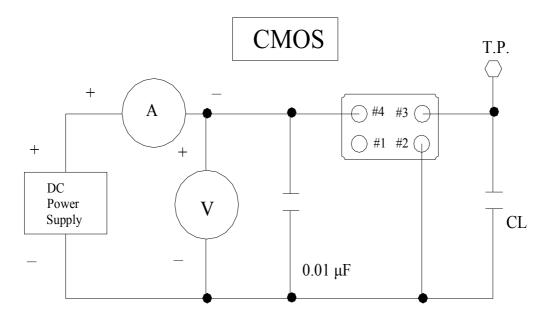


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### 2. C - MOS LOAD OUTPUT WAVEFORM



# **3.C-MOS LOAD TEST CIRCUIT**

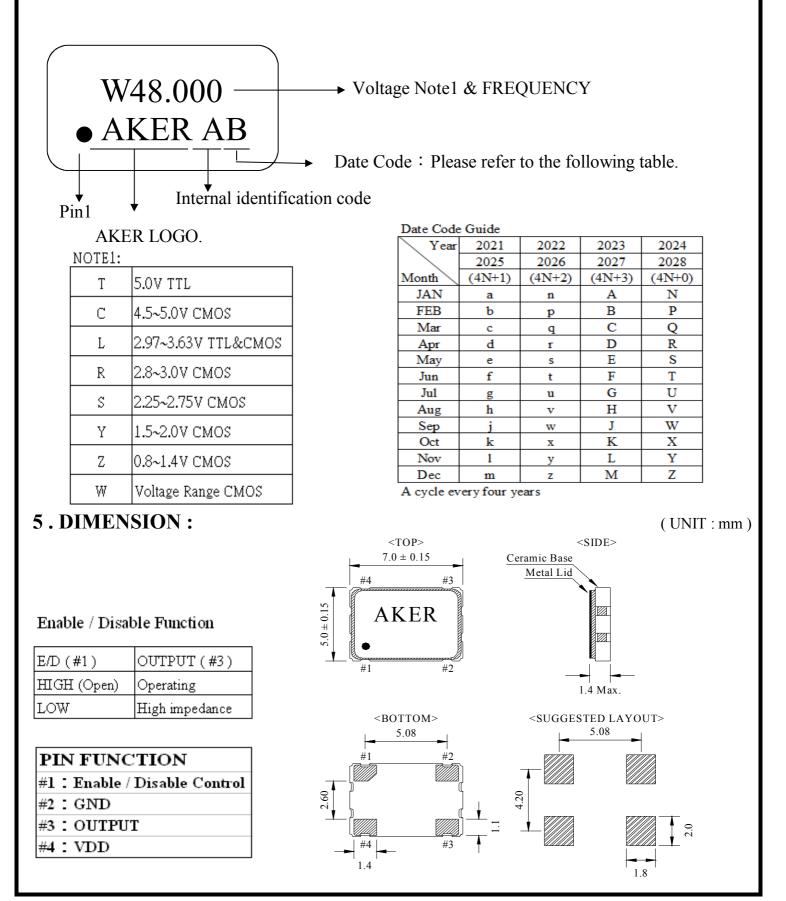


\*\*\*Because SMA series has no by pass capacitor. So,we recommend our customer to use capacitor  $0.01 \ \mu F$  in join Vcc and GND.



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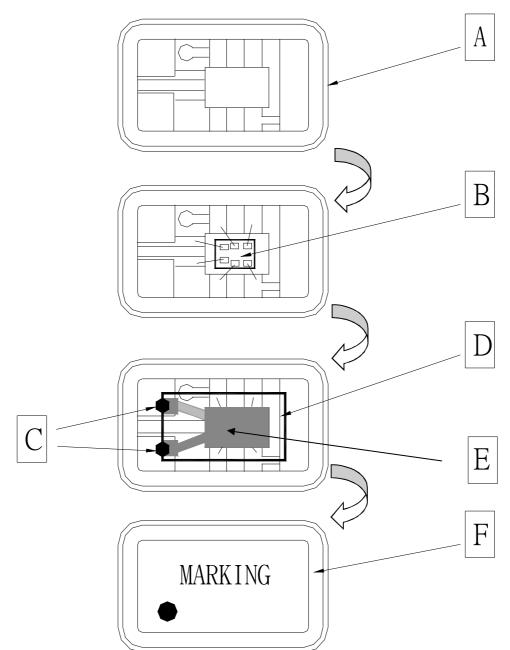
#### 4. MARKING:





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# **6** . STRUCTURE ILLUSTRATION

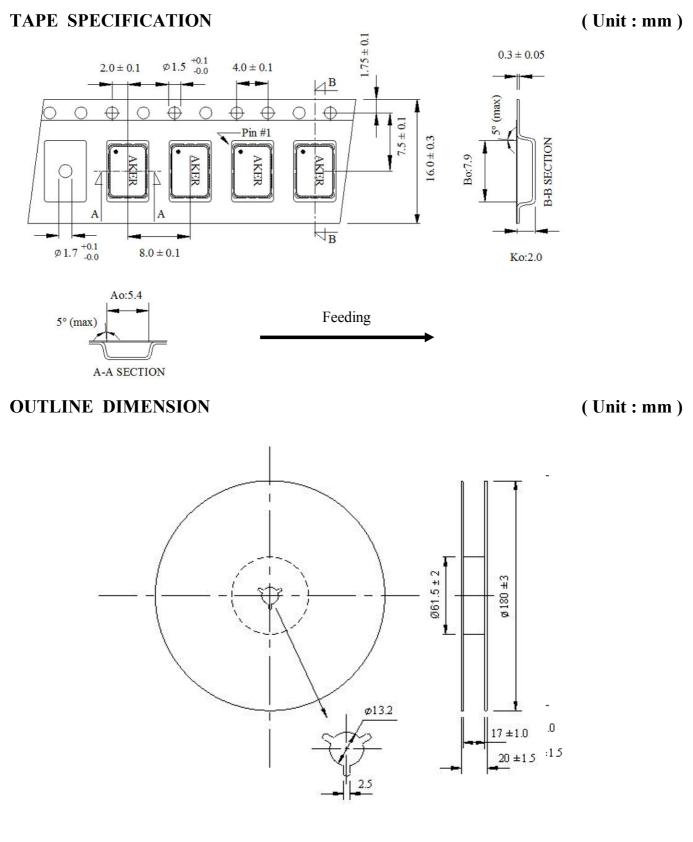


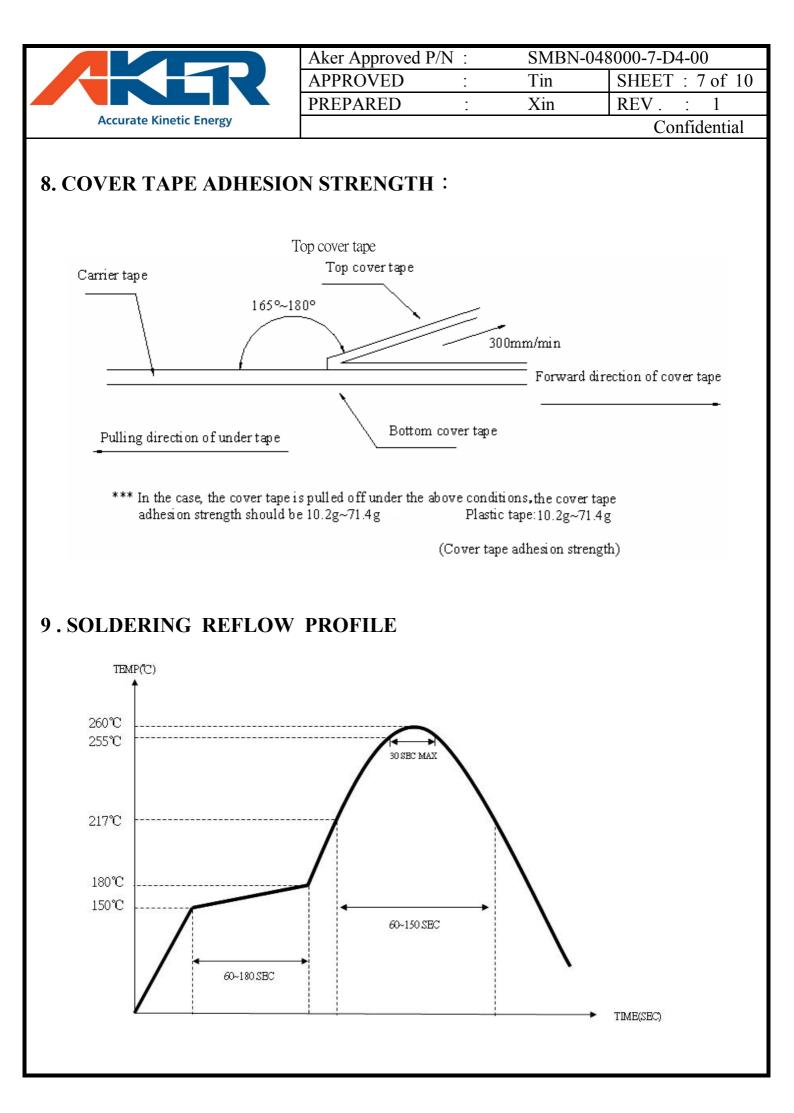
	COMPONENTS	MATERIALS	CO	MPONENTS	MATERIALS
A	Base (Package)	Ceramic (Al2O3)+Kovar (Fe/Co/Ni)	D	Crystal blank	SiO2
В	IC chip		E	Electrode	Cr / Ag
С	Conductive adhesive	Ag / Silicon resin	F	Lid	Fe/Co/Ni

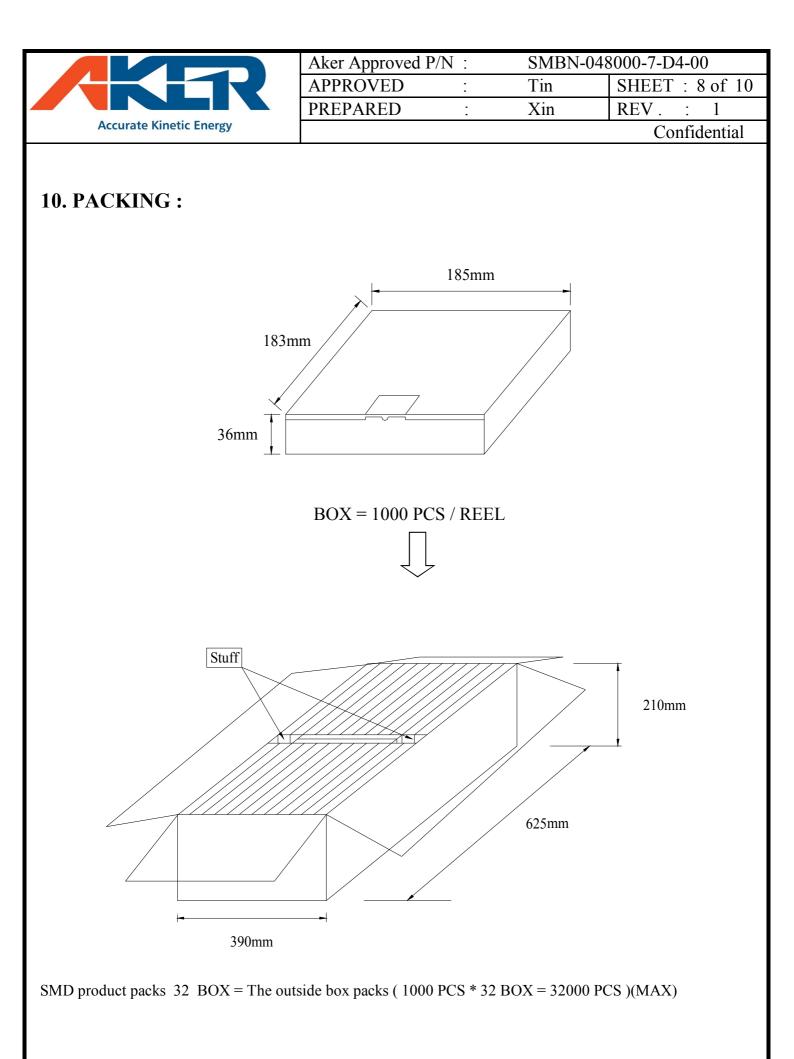


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## 7. PACKING :









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# **11. MECHANICAL PERFORMANCE**

TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE	
11.1 Drop Test	The specimen is measured for its frequency before the test. It is then dropped from a hight of 75 cm or more as a free fall object onto a hard wooden plate of 30mm or more in thickness. ( in accordance with JIS-C0044 )		
11.2 Vibration Test	To satisfy the electrical performance .		
112 Desistance to	( in accordance with MIL-STD-883F : 2007.3 )		
11.3 Resistance to	The specimen is measured for its frequency		
Soldering Test	before the test. Place the specimen on the belt of the convergence and let it pass through		
	the belt of the converynace and let it pass through		
	the reflow with the presetted temperature condition.		
	After passing twice the reflow place, the specimen under the referee condition for $-2$ hours and then		
	measure its electrical performance.		
	Temperature Condition of IR Simulation:		
	The temperature range of the preheated section is setted at $150 \approx 120^{\circ}$ for (0, 120 and For the next		
	is setted at 150 $\sim$ 180 °C for 60~120 sec. For the next		
	section the temperature range is setted at $217 \sim 260^{\circ}$ C		
	for 45~90 sec. and within this time range the specimen		
	should be able to sustain at the peak temperature, $2(0+(2)^{\circ}) = (-1)^{\circ}$		
	$260+/-3^{\circ}$ °C, for 10 sec long.		
11 4 Eine Leele	( in accordance with JESD22-B106-B )		
11.4 Fine Leak	Place the specimen in a pressurized container and	Less than	
Test	pressurize it with the detection gas (mixed gas	$1.0 * 10^{-8}$ atm .c.c. / sec,	
	consisting of 95% or more helium ) for at least 2 hours.	Helium	
	Complete the measurement of the concentration of helium within 30 min after taking it out from the		
	pressurized container.		
	( in accordance with MIL-STD-883F : 1014.11 )		
	The referee condition.	I	
	Temperature $25 \pm 2$ °C Humidity $44 \approx 55.9$		
	Humidity $44 \approx 55 \%$ Pressure $86 \approx 106 \text{ kPa}$		
	( in accordance with MIL-STD-883E : 1014.9 )		



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# **12. CLIMATIC RESISTANCE**

TEST ITEMS	TEST METHODS AND TEST CONDITION	PERFORMANCE
12.1 Low Temp Exposure Test	The specimen is measured for its frequency before the test . Place the specimen in the chamber and kept it at the temperature of $-40 \pm 3^{\circ}$ C for $168 \pm 6$ hours . Take the specimen out of the chamber and measure itselectrical performance after leaving 1 ~ 2 hours under the referee condition. ( in accordance with JIS-C0020 )	
12.2 Aging Test	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and keep it at the temperature of $+125 \pm 3^{\circ}$ C for $720 \pm 48$ hours. And then take the specimen out of the chamber and measure its electrical performance after leaving for 1 ~ 2 hours under the referee condition . ( in accordance with JIS-C0021 )	To satisfy the electrical performance .
12.3 High Temperature & High Humidty	The specimen is measured for its frequency before the test . Place the specimen in the testing chamber and kept it at the temperature of $+85 \pm 5$ °C and humidity of $85 \pm 5$ % for $168 \pm 6$ hours.and then take the specimen out and measure its electrical performance after leaving for 1 ~ 2 hours under the referee condition. ( in accordance with MIL-STD-883F : 1004.7 )	
12.4 Temperature Cycle Test	The specimen is measured for its frequency before the test . Subject the specimen to the 100 cycles of temperature ranges stated below . High temp . + $125 \pm 3 \degree C$ ( $15\pm 3 \min$ ). $2\sim 3 \min$ $2\sim 3 \min$ . Low temp $55 \pm 3 \degree C$ ( $15\pm 3 \min$ ). Measure its electrical performance after leaving it for 1 ~ 2 hours under the referee condition . ( in accordance with MIL-STD-883F : 1010.8 )	